

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/913,955	CRINE ET AL.	
Examiner		Art Unit	1652	Page 1 of 2
Delia M. Ramirez				

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
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	M	US-			

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Page 2 of 2

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